



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Applicant(s): Chiba, T., et al.
Appl. No.: 09/576,681
Conf. No.: 3711
Filed: May 23, 2000
Title: SHAPE OF MICRODOT MARK FORMED BY LASER BEAM AND
MICRODOT MARKING METHOD
Art Unit: 1725
Examiner: Lynne Renee Edmondson
Docket No.: 112780-004

Mail Stop
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 37 C.F.R. 1.97, and 37 C.F.R. 1.98, Applicants request that a citation and examination of the references cited below, and on the attached PTO-1449 form, copies of which are enclosed, be made during the course of examination of the above-identified application for United States patent.

U.S. PATENT DOCUMENTS

<u>Document No.</u>	<u>Date</u>	<u>Inventor</u>
6,268,641 B1	July 31, 2001	Yano et al.

FOREIGN PATENT DOCUMENTS

<u>Document No.</u>	<u>Date</u>	<u>Country</u>
10-004040	January 6, 1998	Japan

The Japanese foreign patent reference listed above is not in the English language. An English language abstract is included for that reference.

Applicants look forward to early and favorable consideration of this matter.

Respectfully submitted,

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BY 

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Dated: September 29, 2003

**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**
(Use several sheets if necessary)

PTO Form 1449

Atty Docket No.
112780-004

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Group
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Examiner's Initials	Document Number	Publication Date	Inventor	Class	Subclass	Filing Date If Appropriate
	6,268,641 B1	07 31 01	Yano et al.			

FOREIGN PATENT DOCUMENTS

Examiner's Initials	Document Number	Publication Date	Country	Class	Subclass	Translation	
						Yes	No
	10-4040	01 06 98	Japan				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner's Initials	

Examiner:

Date Considered:

*Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.